Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | SATO, TAKAHIKO | Examiner | Art Unit | Hien N. Nguyen | 2824 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0199717	10-2004	Kanda et al.	711/106
	В	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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